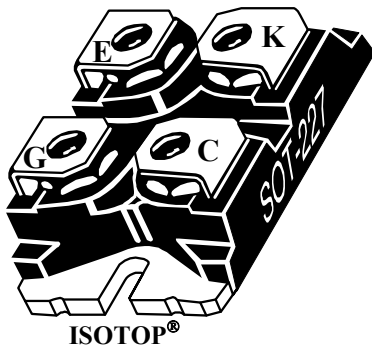
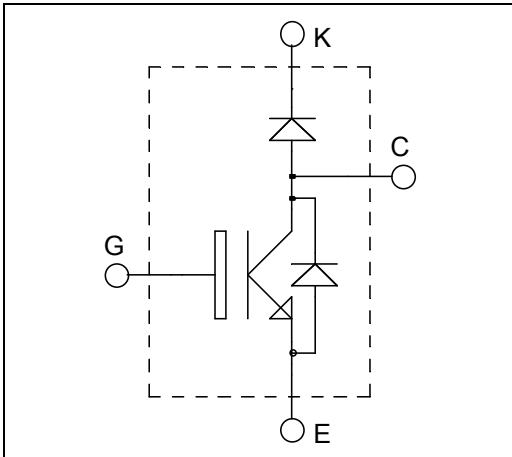


**ISOTOP® Boost chopper  
High speed Trench + Field Stop IGBT4  
Power Module**

**$V_{CES} = 650V$   
 $I_C = 50A @ T_c = 80^\circ C$**


**Application**

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction
- Brake switch

**Features**

- **High speed Trench + Field Stop IGBT 4**
  - Low voltage drop
  - Low leakage current
  - Low switching losses
- ISOTOP® Package (SOT-227)
- Very low stray inductance

**Benefits**

- Low conduction losses
- Stable temperature behavior
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive  $T_C$  of  $V_{CESat}$
- RoHS Compliant

**All ratings @  $T_j = 25^\circ C$  unless otherwise specified**

**Absolute maximum ratings**

<i>Symbol</i>	<i>Parameter</i>	<i>Max ratings</i>	<i>Unit</i>
$V_{CES}$	Collector - Emitter Voltage	650	V
$I_C$	Continuous Collector Current	$T_C = 25^\circ C$	80
		$T_C = 80^\circ C$	50
$I_{CM}$	Pulsed Collector Current	$T_C = 25^\circ C$	140
$V_{GE}$	Gate - Emitter Voltage	$\pm 20$	V
$P_D$	Power Dissipation	220	W

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed

**Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 650V$			50	$\mu A$
$V_{CE(sat)}$	Collector Emitter Saturation Voltage	$V_{GE} = 15V$ $I_C = 50A$	$T_j = 25^\circ C$ 1.4	1.85	2.3	V
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 0.8 mA$	4.2	5.1	5.6	V
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$			150	nA

**Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$C_{ies}$	Input Capacitance	$V_{GE} = 0V$		3100		pF
$C_{oes}$	Output Capacitance	$V_{CE} = 25V$		116		
$C_{res}$	Reverse Transfer Capacitance	$f = 1MHz$		90		
$Q_G$	Gate charge	$V_{GE} = 15V, I_C = 50A$ $V_{CE} = 480V$		315		nC
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C) $V_{GE} = \pm 15V$ $V_{Bus} = 400V$ $I_C = 50A$ $R_G = 7\Omega$		19		ns
$T_r$	Rise Time			33		
$T_{d(off)}$	Turn-off Delay Time			197		
$T_f$	Fall Time			21		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C) $V_{GE} = \pm 15V$ $V_{Bus} = 400V$ $I_C = 50A$ $R_G = 7\Omega$		19		ns
$T_r$	Rise Time			29		
$T_{d(off)}$	Turn-off Delay Time			227		
$T_f$	Fall Time			22		
$E_{on}$	Turn on Energy	$V_{GE} = \pm 15V$ $V_{Bus} = 400V$ $I_C = 50A$	$T_j = 150^\circ C$	1.2		mJ
$E_{off}$	Turn off Energy	$R_G = 7\Omega$	$T_j = 150^\circ C$	1		
$I_{sc}$	Short Circuit data	$V_{GE} \leq 15V; V_{Bus} = 400V$ $t_p \leq 5\mu s; T_j = 150^\circ C$		350		A
$R_{thJC}$	Junction to Case Thermal Resistance				0.68	$^\circ C/W$

**Chopper diode ratings and characteristics**

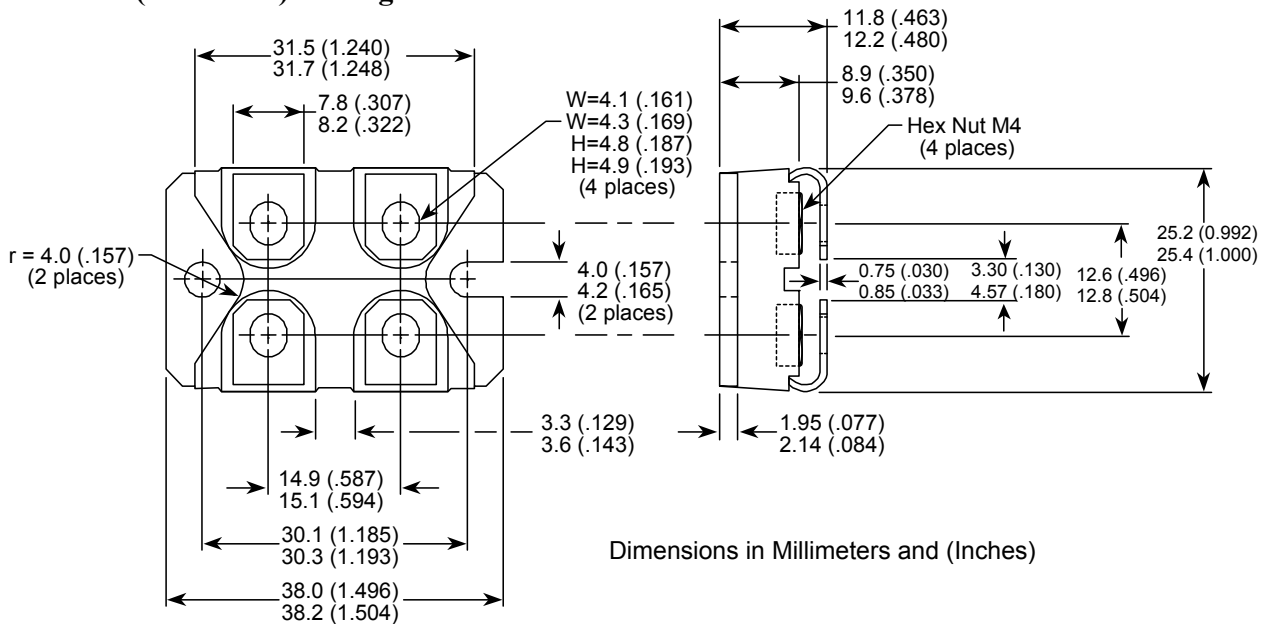
Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$V_{RRM}$	Peak Repetitive Reverse Voltage				650	V
$I_{RM}$	Reverse Leakage Current	$V_R = 650V$			50	$\mu A$
$I_F$	DC Forward Current		$T_c = 25^\circ C$	50		A
$V_F$	Diode Forward Voltage	$I_F = 50A$ $V_{GE} = 0V$	$T_j = 25^\circ C$ 1.6		2	V
$t_{rr}$	Reverse Recovery Time	$I_F = 50A$ $V_R = 300V$ $di/dt = 1800A/\mu s$	$T_j = 150^\circ C$	1.5		ns
			$T_j = 25^\circ C$	100		
$Q_{rr}$	Reverse Recovery Charge		$T_j = 150^\circ C$	150		$\mu C$
			$T_j = 25^\circ C$	2.6		
			$T_j = 150^\circ C$	5.4		
$E_{rr}$	Reverse Recovery Energy	$T_j = 25^\circ C$	0.6		mJ	
		$T_j = 150^\circ C$	1.2			
$R_{thJC}$	Junction to Case Thermal Resistance				1.14	$^\circ C/W$

**IGBT parallel diode ratings and characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage				650	V
I <sub>RM</sub>	Reverse Leakage Current	V <sub>R</sub> = 650V			50	μA
I <sub>F</sub>	DC Forward Current	T <sub>c</sub> = 60°C		20		A
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 20A V <sub>GE</sub> = 0V	T <sub>j</sub> = 25°C	1.6	2	V
			T <sub>j</sub> = 150°C	1.5		
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 20A V <sub>R</sub> = 300V di/dt = 1600A/μs	T <sub>j</sub> = 25°C	100		ns
			T <sub>j</sub> = 150°C	150		
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 20A V <sub>R</sub> = 300V di/dt = 1600A/μs	T <sub>j</sub> = 25°C	1.1		μC
			T <sub>j</sub> = 150°C	2.3		
E <sub>rr</sub>	Reverse Recovery Energy	I <sub>F</sub> = 20A V <sub>R</sub> = 300V di/dt = 1600A/μs	T <sub>j</sub> = 25°C	0.23		mJ
			T <sub>j</sub> = 150°C	0.50		
R <sub>thJC</sub>	Junction to Case Thermal Resistance				2.6	°C/W

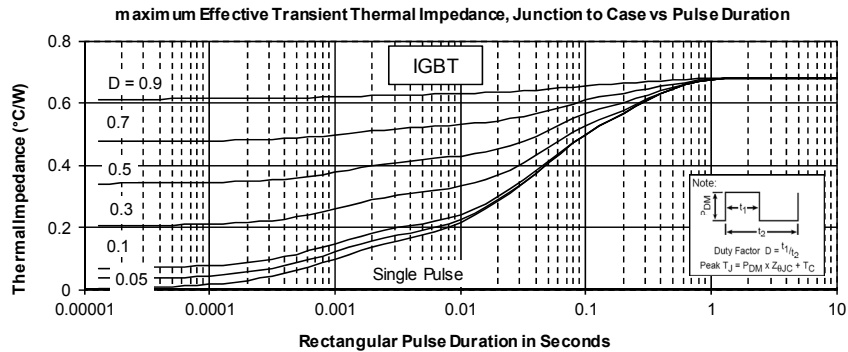
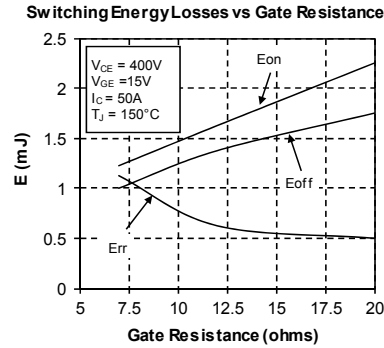
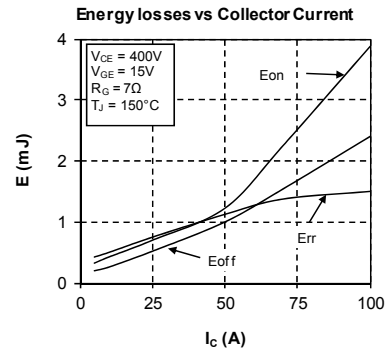
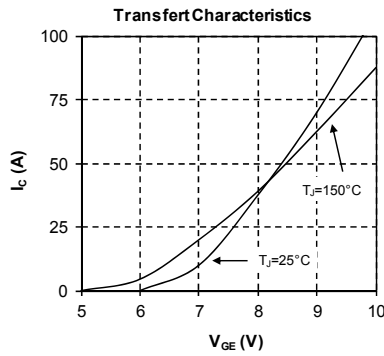
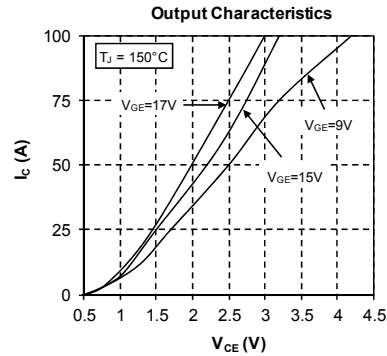
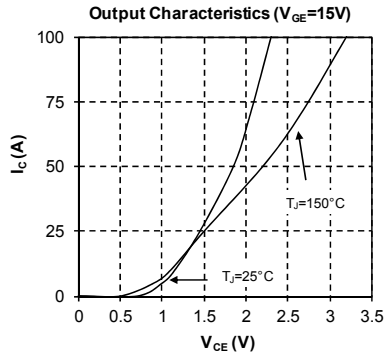
**Thermal and package characteristics**

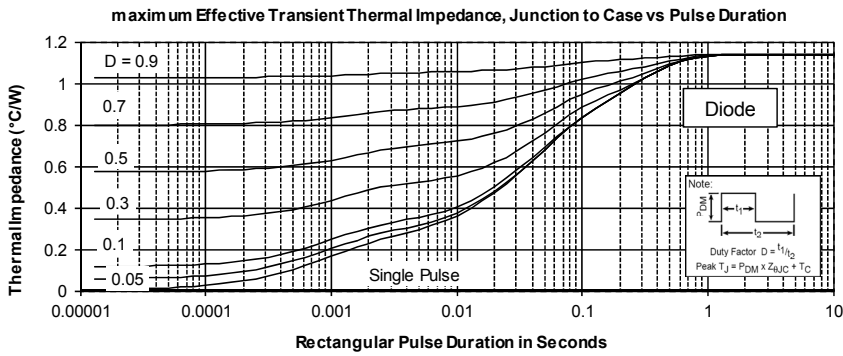
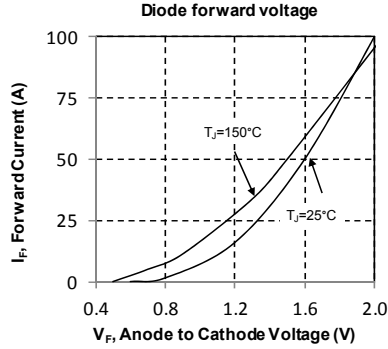
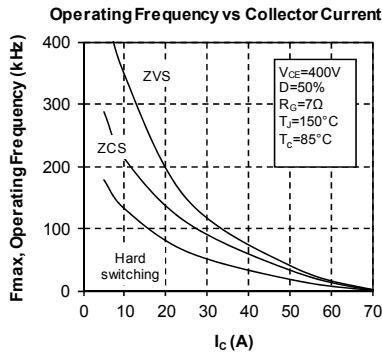
Symbol	Characteristic	Min	Typ	Max	Unit
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz	2500			V
T <sub>J</sub> , T <sub>STG</sub>	Storage Temperature Range	-55		175	°C
T <sub>JOP</sub>	Recommended junction temperature under switching conditions	-55		T <sub>j</sub> max -25	
T <sub>L</sub>	Max Lead Temp for Soldering: 0.063" from case for 10 sec			300	
Torque	Mounting torque (Mounting = 8-32 or 4mm Machine and terminals = 4mm Machine)			1.5	N.m
Wt	Package Weight		29.2		g

**SOT-227 (ISOTOP®) Package Outline**


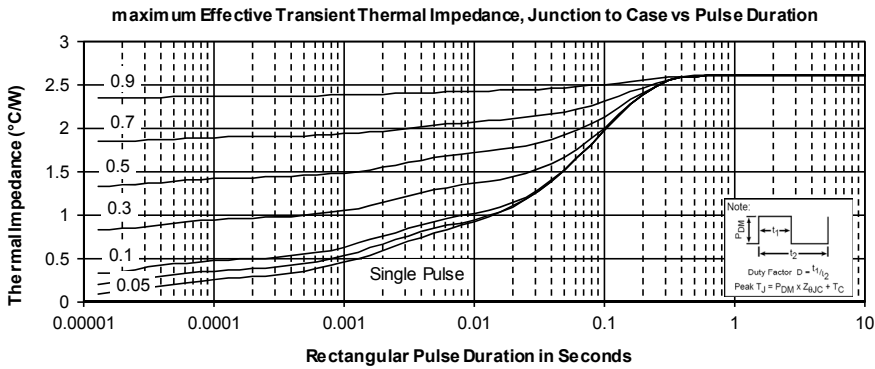
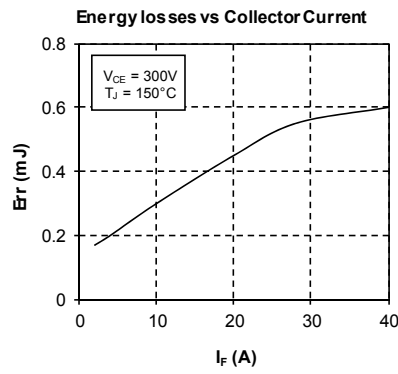
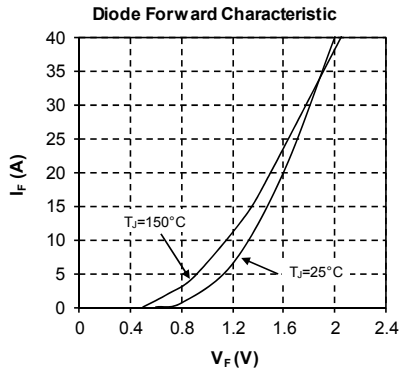
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## IGBT & Chopper diode Typical Performance Curves





## IGBT parallel diode Typical Performance Curves



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